

IN THE
UNITED STATES PATENT AND TRADEMARK OFFICE

Inventor(s): John Wuu et al.

Confirmation No.:

Application No.:

Examiner:

Filing Date: Jun. 20, 2003

Group Art Unit:

Title: PROGRAMMABLE WEAK WRITE TEST MODE (PWWTM) BIAS GENERATION HAVING LOGIC HIGH OUTPUT DEFAULT MODE

**Commissioner for Patents
PO Box 1450
Alexandria, VA 22313-1450**

INFORMATION DISCLOSURE STATEMENT

Sir:

This Information Disclosure Statement is submitted:

under 37 CFR 1.97(b), or
(Within three months of filing national application; or date of entry of national application; or before mailing date of first office action on the merits; whichever occurs last)

under 37 CFR 1.97(c) together with either a:
 Statement under 37 CFR 1.97(e), or
 a \$180.00 fee under 37 CFR 1.17(p), or
(After the CFR 1.97 (b) time period, but before final action or notice of allowance, whichever occurs first)

under 37 CFR 1.97 (d) together with a:
 Statement under 37 CFR 1.97(e)(1) or (2), and
 a \$180.00 fee set forth in 37 CFR 1.17(p).
(Filed after final action, a notice of allowance, on or before payment of the issue fee)

Please charge to Deposit Account **08-2025** the sum of \$0.00. At any time during the pendency of this application, please charge any fees required or credit any overpayment to Deposit Account **08-2025** pursuant to 37 CFR 1.25.

Applicant(s) submit herewith Form PTO 1449 - Information Disclosure Citation together with copies, of patents, publications or other information of which applicant(s) are aware, which applicant(s) believe(s) may be material to the examination of this application and for which there may be a duty to disclose in accordance with 37 CFR 1.56.

A concise explanation of the relevance of foreign language patents, foreign language publications and other foreign language information listed on PTO Form 1449, as presently understood by the individual(s) designated in 37 CFR 1.56 (c) most knowledgeable about the content is given on the attached sheet, or where a foreign language patent is cited in a search report or other action by a foreign patent office in a counterpart foreign application, an English language version of the search report or action which indicates the degree of relevance found by the foreign office is listed on form PTO 1449 and is enclosed herewith.

It is requested that the information disclosed herein be made of record in this application.

"Express Mail" label no. **EO 901 007 092 US**

Date of Deposit **Jun. 20, 2003**

Respectfully submitted,

John Wuu et al.

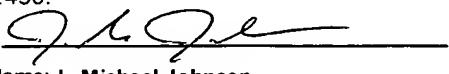
By 

J. Michael Johnson

Attorney/Agent for Applicant(s)
Reg. No. **37,856**

Date: **Jun. 20, 2003**

I hereby certify that this is being deposited with the United States Postal Service "Express Mail" Post Office to Addressee" service under 37 CFR 1.10 on the date indicated above and is addressed to: Commissioner for Patents, Alexandria, VA 22313-1450.

By 

Typed Name: **J. Michael Johnson**

PATENT APPLICATION

Sheet 1 of 1

FORM PTO-1449		ATTY. DOCKET NO. 200207084-1	APPLICATION NO.	CONFIRMATION NO.
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT		APPLICANT John Wuu et al.		
(Use several sheets if necessary)		FILING DATE Herewith	GROUP	

REFERENCE DESIGNATION U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	PUBLICATION DATE	NAME	Pages, Columns, Lines Where Relevant Passages or Figures Appear
1A	6,256,241 B1	Jul. 3, 2001	Mehalel	
1B	6,501,692 B1	Dec. 31, 2002	Melanson et al.	
1C				
1D				
1E				
1F				
1G				
1H				
1I				
1J				
1K				

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	PUBLICATION DATE	NAME OF PATENTEE OR APPLICANT	Pages/Columns/Lines Where Relevant Passages/Figures Appear	Check if Translation attached
	1L					
	1M					
	1N					
	1O					
	1P					

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

1Q	Sanjay Sengupta et al., "Defect-Based Test: A Key Enabler for Successful Migration to Structural Test," Intel Technology Journal, Q1, 1999, pp. 1-14.
1R	
1S	

EXAMINER

DATE CONSIDERED